

Search Notes

Application/Control No.

10/021,294

Examiner

Leigh C. Maier

Applicant(s)/Patent under
Reexamination

PUN ET AL.

Art Unit

1623

SEARCHED

| Class | Subclass | Date | Examiner |
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| search | updated | | |
| from | 3/5/06 | 7/6/2006 | LCM |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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| 424 | 280.1 489 | 7/6/06 | LCM |
| | 497 499 | | |
| 435 | 486 6,69.1 | | |
| | 72,455 458 | | |
| 514 | 44,54 | | |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-------------------------|----------|------|
| -Search updated in EAST | 7/6/2006 | LCM |
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